

08/24/00	2	Subclass	ISSUE CLASSIFICATION
378	Class		

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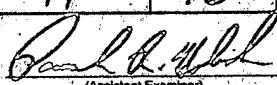
PATENT NUMBER

U.S. UTILITY Patent Application

O.I.P.E.	PATENT DATE
SCANNED	04/04/01

APPLICATION NO.	CONT/PRIOR	CLASS	SUBCLASS	ART UNIT	EXAMINER
09/533778	F	378	21	2876 2882	1111 SMG Prokes
APPLICANT'S Name: Akira Teraoka					
TITLE: X-ray inspection method and apparatus used for the same					
PTO-2040 12/99					

ISSUING CLASSIFICATION					
ORIGINAL		CROSS REFERENCE(S)			
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)		
378	21	378	24	25	
INTERNATIONAL CLASSIFICATION		230	559.44		
<input type="checkbox"/> Continued on Issue Slip Inside File Jacket					

<input type="checkbox"/> TERMINAL DISCLAIMER	DRAWINGS		CLAIMS ALLOWED	
	Sheets Drwg.	Figs. Drwg.	Print.Fig.	Total Claims
	14	16	67	14
<input type="checkbox"/> The term of this patent subsequent to _____ (date) has been disclaimed.	 (Assistant Examiner)  (Primary Examiner) (Date)		NOTICE OF ALLOWANCE MAILED 9/30/01	
<input type="checkbox"/> The term of this patent shall not extend beyond the expiration date of U.S Patent No. _____				
<input type="checkbox"/> The terminal _____ months of this patent have been disclaimed.			ISSUE FEE	
			Amount Due	Date Paid
			ISSUE NUMBER	

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(Rev. 8/99)

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(FACE)